

THE CROSS SECTIONAL INVESTIGATIONS OF POROUS CARBON FILMS CONTAINING PALLADIUM NANOCRYSTALLITES

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INTRODUCTION

The problem of detection hydrogen and also hydrocarbons with sufficient sensitivity is very important. The future of aerospace, automobile and energy sectors will revolve around hydrogen fuel. It becomes really important to control and monitor these gases, as there is a huge risk of damage to property and loss of human health if a leak occurs. Certain gases can be toxic for humans, corrosive and also explosive. So we need sensors that can continuously and effectively detect the gases. In Tele- & Radio Research Institute such films, containing palladium nanograins were synthesized and can be applied as active layer in hydrogen detector.

SAMPLE PRODUCTION

In PVD method multiphase carbonaceous Pd films were deposited on ceramic substrates under the dynamic pressure of 10-5 mbar. Two separated sources were used: one containing fullerene C_{60} powder (99,9%) and second with palladium acetate $Pd(C_2H_3O_2)_2$. During the synthesis process the temperature of the substrates was $\sim 100^\circ C$ and growing time was 8 min. The film originating from the PVD process was modified in the CVD method due to temperature and xylene decomposition over the film surface. structure containing Pd nanograins was obtained. More information about this process [1] [2]. The PVD film is presented on Fig.1 and the PVD/CVD film on Fig.2.

SAMPLE PREPARATION

For TEM research, we have prepared cross-sections specimens (lamella) of both samples obtained after PVD and PVD/CVD process using the Focus Ion Beam (FIB) from Helios Nanolab 600i. First, the film surface has been protected by the platinum layer. Then the protected layer was cut out using the gallium ions beam. This method was not destructive for the studied samples. Finally, the lamella was soldered to the standard Omniprobe Lift-Out grids. View of the both lamella are presented on Fig.3 PVD and Fig.4 PVD/CVD films. Dimensioned individual layers of the lamella.

RESULTS

The carbonaceous films obtained in the PVD and PVD/CVD process were studied by TEM, using TITAN CUBED 80 - 300 and JEOL 2000 EX. Sample from PVD process (Fig.5) showed the existence of large crystallites of palladium (~ 20 to 100 nm) which are surrounded by a layer of amorphous carbon containing small Pd crystallites ($1-3$ nm). Fig.6. In sample PVD/CVD we observed that the particles of the Pd are larger (Fig.6) some reach the size of 300 nm. Graphitization is observed on the walls of Pd (Fig.8), which is the cause of decomposition of amorphous carbon surrounding the Pd particles. The difference between layer obtained in PVD/ CVD is the existence of a carbon foam layer covering the layer formed by PVD (Fig.7). Big Pd particles has a polycrystalline structure (Fig.9). Are observed, as in the PVD samples, clusters of small nanocrystallites of Pd Fig.8.

CONCLUSIONS

Traditional sample preparation method using epoxy glue and ion milling in the case of such thin films is practically impossible. The use of Helios allows the production cross section while minimizing damage beyond the sample. This method allows for accurate measurement of thickness of layer occurring in the sample.

Fig. 1. Plan view of the PVD film

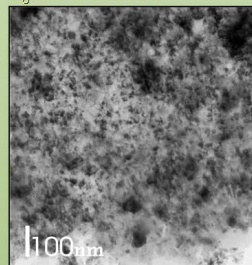


Fig. 2. Plan view of the CVD film

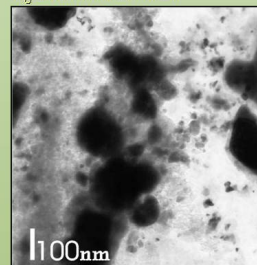


Fig. 3. Lamella of the PVD film

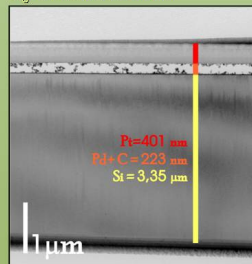


Fig. 4. Lamella of the PVD/CVD film

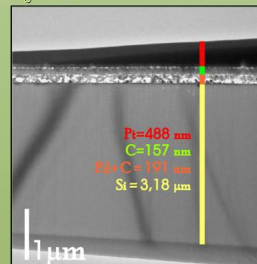


Fig. 5. The PVD cross section

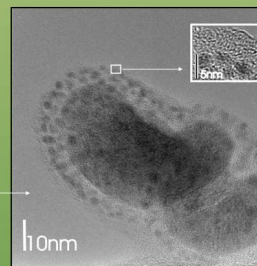
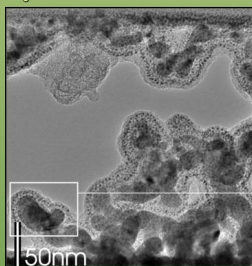


Fig. 6. The PVD/CVD cross section

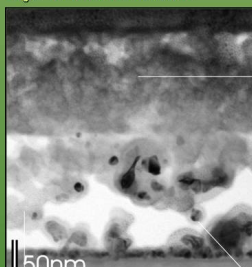


Fig. 7. Part of the amorphous carbon

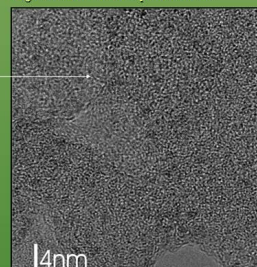


Fig. 8. Nanocrystallites Pd

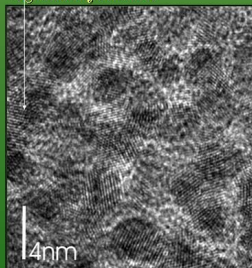
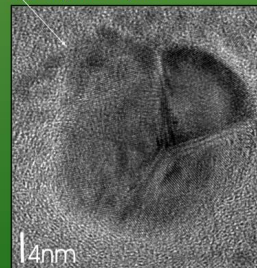


Fig. 9. big Pd nanocrystallites



[1] E. Kowalska, E. Czerwosz, J. Radomska „METODA SYNTEZY NANOPOROWATYCH MATERIAŁÓW WĘGLOWO - PALLADYOWYCH” Elektronika 1/2009

[2] Sposób otrzymywania nanopianki węglowej zawierającej nanokrystality metalu E. Czerwosz, E. Kowalska, J. Radomska, H. Wronka zgłoszenie patentowe nr P384591 z dnia 03.03.2008r.

